Se	arcn	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/776,248	OTSUKI ET AL.	
Examiner	Art Unit	
Zoila E. Cabrera	2125	

SEARCHED			
Class	Subclass	Date	Examiner
700	186, 192-195	6/6/06	R
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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